## D ynam ical Self-assem bly during C olloidal D roplet E vaporation Studied by in situ Sm all A ngle X -ray Scattering

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The nucleation and growth kinetics of highly ordered nanocrystal superlattices during the evaporation of nanocrystal colloidal droplets was elucidated by in situ time resolved small-angle x-ray scattering. We demonstrated for the rst time that evaporation kinetics can a ect the dimensionality of the superlattices. The form ation of two-dimensional nanocrystal superlattices at the liquid-air interface of the droplet has an exponential growth kinetics that originates from interface "crushing".

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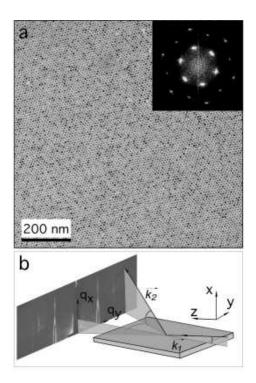
The microscopic mechanism for self-organization of ligand-stablized nanocrystals has been well established [1, 2]. The interparticle van der W aals interaction provides the attractive force to induce the self-assembly, whereas the steric interaction due to the ligand interdigitation provides the balancing force to create stable structures. However, the macroscopic patterns created by such interactions can vary dramatically under di erent experim ental conditions. Even for a sim ple case of evaporating a colloidal droplet of nanocrystals on a surface, a variety of patterns have been reported, ranging from ordered two-dimensional(2D), three-dim ensional (3D) nanocrystal superlattices (NCSs) [3, 4, 5], fractal-like aggregates [6, 7] to m ore percolated networks [8, 9, 10]. A common notion is that the selfassembling process occurs at the liquid-substrate interface [11], where the competing e ect from the di usion of nanocrystals along the substrate and solvent dew etting could lead to pattern form ation far away from equilibrium [12]. Having such vast di erent macroscopic structures of nanocrystal assembly hinders the exploration of their physical properties [3, 13, 14], as well as creating obstacles for device applications [11, 15]. It is therefore essential to further understand and control the nanocrystal self-assem bly mechanism.

Recently, it has been shown that highly ordered 2D NCSs with domain size up to tens of microns, can be form ed on a silicon nitride substrate by evaporating a nanocrystalcolloidaldroplet with slight excess am ount of dodecanethiol ligand molecules in the solution [5]. Figure 1a shows a transmission electron microscopy (TEM) im age of a region of such highly ordered NCSs. The high degree of ordering and large domain size indicates the form ation of NCSsm ost likely occurs through nucleation and grow th mechanism. It is di cult, how ever, to explain the high crystallinity of the superlattices through a mechanism in which self-assem bly occurs on the substrate at the last instance when the solvent dewets the surface.

In this letter, we report an in situ, non-intrusive, sm all angle x-ray scattering (SAXS) measurement to elucidate the formation of NCSs as the colloidal droplet evaporates. We show that, contrary to the previous notion, these highly ordered 2D superlattices are formed at the liquid-air interface of the liquid droplet during the solvent evaporation. Changing the solvent evaporation rate can lead to either 2D or 3D NCS formation using the same colloidal nanocrystals.

W e used m onodispersed gold nanocrystals with an average diameter of 7.5 nm and 5.8 nm in two di erent experimental runs [16, 17], respectively, and with the particle number concentration adjusted to be approxim ately  $10^{13}$  m L<sup>1</sup>, just enough to form a monolayer. The volum e concentration of thiolwas 0.63%. The SAXS experiments were conducted at the 1-BM beam line of the Advanced Photon Source (APS). 10 lof colloidal solution was deposited onto a rectangular silicon nitride 4mm<sup>2</sup>). The incident synchrotron x-ray substrate (3 beam was monochromatized to 8.0 keV by a doublecrystalm onochrom ator while two sets of horizontal (H) and vertical (V) slits were used to de ne the beam size to 0.2 (H) 0.2 (V)mm<sup>2</sup>. We chose a laboratory coordinate system as shown in Figure 1b so that the incident x-ray beam is along the z-direction and the substrate surface is in the y-z plane. The sam ples were initially aligned using the substrate as a reference, thus the top surface of the substrate was centered in the x-ray beam along the x-direction. During the experiment, the substrate was slightly titled with an angle of 03° relative to the incident beam. The scattered x-rays passed through a helium ight path and were collected by either an im age plate (IP) or a charge-coupled device (CCD) detector.

The dynam ical self-assem bling process can be observed by positioning the incident beam at the bottom center of the droplet to accom m odate the changing m eniscus of the droplet as it evaporates. Figure 2 shows a typical tim e evolution of the SAXS patterns after the droplet is de-



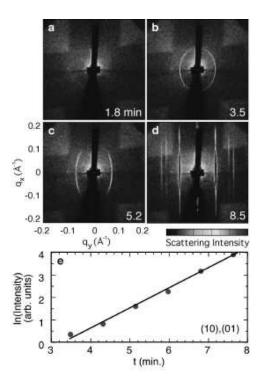


FIG. 1: Characterization of 2D nanocrystal superlattices form ed by colloidal droplet evaporation: (a) Transm ission electron m icroscopy (TEM) im age of a highly ordered gold nanocrystalm onolayer. Inset shows Fourier transform ation of the superlattice. (b) Schem atic diagram of scattering geom etry used for the in situ SAXS m easurem ent. The dim ension of the substrate is exaggerated in order to clearly illustrate the experim ental setup.

posited on the substrate. The droplet is evaporated in air at room temperature  $(23^{\circ}C)$  with the mass of the droplet decreasing approxim ately at 0.66m g perm inute. The initial thickness of the droplet is typically more than 2 mm. No visible scattering pattern is observed in the rst two m inutes indicating that, initially, there are no ordered superstructures in the droplet (Figure 2a). A fler that, an elliptically shaped di raction ring is observed (Figure 2b). The section of the scattering ring near  $q_v = 0$  gradually becomes more di use in the g-direction and eventually disappears, while the intensity of the scattering corresponding to the in-plane long-range order increases dram atically (Figures 2c-2d). The scattering pattern in Figure 2d remains unchanged for hours during which a thin liquid lm, less than 100 m in thickness, with a high concentration of dodecanethiol remains on the substrate surface. To illustrate the kinetics of the nanocrystal array grow th, Figure 2e shows the experim ental time evolution of the intensity of the (10) powder di raction peak at  $q_x = 0$ , plotted in a sem i-natural log form at. The scattering intensity increases exponentially with time before becoming saturated after 8 minutes (data not shown). W hen the liquid Im is completely dried and the NCSs are deposited directly on the substrate, the downward

FIG.2: (a-d)In situ SAXS patterns of 2D NCSs form ation during the droplet evaporation. Time in unit of minute is in reference to the deposition of colloid droplet. The average diameter of the nanocrystals is 7.5 nm determined by TEM. Cross bar feature in each frame is the shadow im age of the beam stop. (e) Time-evolution of the normalized scattering intensity of the monolayer powder diraction peak for (10) powder diraction peak (solid line is a linear t to the data).

scattering is blocked by the substrate in the grazing incidence geometry [18, 19]. In contrast, the scattering patterns in the liquid lm (Figure 2d) is highly symmetric in the vertical direction  $(q_x)$ , indicating the 2D NCSs are form ed at the liquid-air interface which is elevated above the substrate. The self-assem bly of nanocrystals at the liquid-air interface was further con med by using a wider x-ray beam measured to be 1.5 (H) 0.2 (V)mm<sup>2</sup>, purposely positioned near the edge of the droplet [20]. Bragg di raction patterns from the 2D NCSs were observed rotating along with the direct re ection of meniscus surface as the droplet attens due to evaporation. We should em phasize that, unlike experiments carried out on the Langmuirtrough [21], no aqueous subphase was used in our experiments. Both the nanocrystal ligand and the toluene solvent are hydrophobic in nature.

A com prehensive understanding of the form ation of the 2D NCS m onolayer, including the early stage scattering ring, can be achieved by com paring the simulated SAXS patterns during the entire evaporation process with the experimental data. The initial elliptically-shaped x-ray scattering patterns as well as its evolution can be modelled by the "powder" di raction of 2D superlattice dom ains with varying x-ray incident angles. As shown in

the schematic cross section diagram in Figure 3A, the x-ray incident angle at the liquid-air interface varies during the droplet evaporation (while the edges of the droplet are pinned at the substrate). To model the xray scattering patterns from the 2D lattices with their lattice plane orientation changing with time, we de ne a sample coordinate system  $(x^0; y^0)$  that is attached to the lattice plane as shown in Figure 3a. In a kinem aticalapproach of x-ray di raction 22], the averaged powder di raction intensity from many 2D lattice domains in the reciprocal space is distributed in a circular ring  $q_{k^0}^2 + q_{y^0}^2 = jq_{h,k} j$  where  $(q_{k^0}; q_{y^0})$  are the de ned by momentum transfer (MT) components in the sample coordinates which satis es the Bragg di raction condition dened by the scattering vector  $q_{1,k}$ . The scattering patterns recorded by the 2D detectors in the laboratory space are related to the circular powder ring in the sam ple space by a linear transform ation between the two coordinates. Therefore the Bragg scattering condition in the laboratory coordinate is described approxim ately by  $(q_x \sin)^2 + q_y^2 = jq_{h,k} j$ , where  $(q_x;q_y)$  are the MT com ponents in laboratory coordinate. The short axis of the ellipse is in the  $q_v$ -direction and has a magnitude of  $jq_{h,k}$  j whereas the long axis is in the  $q_k$ -direction and has a magnitude of  $jq_{h,k} \neq sin$  . For example, the elliptical scattering pattern in Figure 2b indicates, at 3.5 m inutes into the evaporation process, the 2D NCSs form ed at the interface which is orientated about 52.4° with respect to the incoming x-ray beam. The complete scattering intensity is the product of the lattice structure factor and the form factor of a spherical nanocrystal expressed as  $f(q) = j \frac{(\sin (qr) - qr \cos (qr))}{(qr)^3} dr$ , where q = $q_{x}^{2} + q_{z}^{2} + q_{z}^{2}$ and r is the radius of the sphere. As the liquid droplet evaporates, the scattering geom etry approaches a grazing incidence angle with respect to the sample  $(=0.3^{\circ})$ . In this case, the scattering intensity distribution along the qy-direction corresponds to the structure factor of the inplane lattice and that along  $q_x$  reveals the form factor of the individual nanocrystal. Figures 3b-e show the sim ulation results at di erent stages of evaporation, based on a 2D hexagonal close-packed m onolayer of nanocrystals with an average diameter of 7.5 nm (polydispersity of 7%) and a 10.3 nm center-to-center spacing. Because the incident angle can be deduced from the simulation, it is possible to obtain the NCS scattering intensity normalized by the x-ray beam footprint size. This allows a precise determ ination of the self-assembly kinetics. The xray scattering intensity data shown in Figure 2e is found to be proportional to the integrated intensity after being normalized by the changing x-ray footprint size on the sample due to the variation of x-ray incident angle.

The form ation of the 2D NCSs can be understood using a kinetic "crushing" model proposed by Nguyen and W it-ten [23]. The di usion constant (D) of the nanocrystals

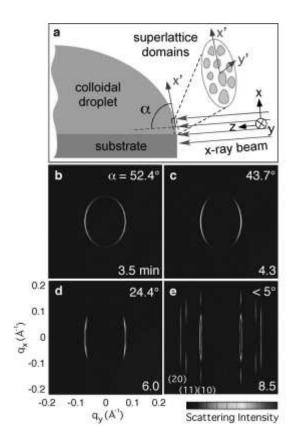


FIG. 3: Simulation results of the SAXS experiments. (a) Schematic cross sectional diagram of the x-ray beam and the colloidal droplet. (b)-(e) Simulation results based on a monolayer of 2D domains oriented at an angle with respect to the incident x-ray beam at the liquid-air interface. The time in each fram e corresponds to the real time used in our experiments.

with a hydrodynam ic radius R (5.1 nm) can be estimated using the Stokes-E instein relation (D =  $k_B T = 6$  R) and the viscosity of dodecanethiol (= 2.98 cp), assuming that toluene com pletely evaporates near the liquid-air interface. Since the major change in scattering patterns in Figure 2 occurs at a tim e scale of one m inute, we can com pare the di usion distance of nanocrystals in one m inute with the change of liquid-air interface during the same time interval. Performing a random walk, the average distance a nanocrystal can di use within one minute is 6Dt 70 m. Since the air-liquid interface  $< r^2 > =$ decreases faster than 70 m/m in during the initial evaporation, as m easured by m on itoring the thickness change of the droplet in real-time, nanocrystals will accumulate at the 2D liquid-air interface and eventually induce 2D crystallization.

The exponential increase of the scattering intensity (Figure 2e) also supports the interface "crushing" model, in contrast to the power law behavior in the conventional 2D di usion coarsening mechanism [24]. In the "crushing" case, the dom ain growth mainly occur through incorporating nanocrystals in pinging the dom ain surface

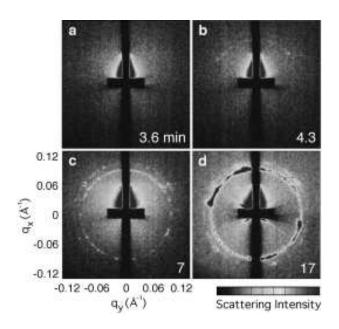


FIG. 4: In situ scattering patterns obtained during a slow evaporation of the colloid droplet. In this experiment, the average diameter of nanocrystals is 5.8 nm determined by TEM. These patterns were recorded by the CCD detector.

from below when it collapses with the evaporating liquidair interface. The collected nanocrystals either llthe vacant sites orm ove to the edge of the dom ain. The grow th rate of a dom ain with size S is dS=dt nSv, where n is density of nanocrystal and v is the collapsing rate of interface. We note approxim ately n and v remains constant during m ost of the evaporation process. The "crushing" e ect thus leads to an exponential grow th of dom ain size, which is a much m ore dom inant process than the powerlaw grow th by 2D di usion at the interface.

One prediction of this kinetic "crushing" model is that the form ation of the 2D NCSs should be a ected by the initial evaporation rate. A slower initial evaporation rate could allow the nanocrystals to di use away from the interface before the nanocrystal concentration reaches its critical value for 2D crystallization. The form ation of superlattices will then occur in the bulk of the droplet once the overall concentration of nanocrystals in the droplet exceeds a critical concentration for 3D nucleation. Figure 4 shows the time evolution of scattering patterns when the droplet is evaporated at approximately 0.22m g per m inute, much slower than the ambient condition. Indeed, 3D superlattices form and persist during the entire evaporation process. Using the same colloidal solution, but through varying the evaporation rate, both the 2D NCSs and 3D NCSs form ation can be reproduced consistently.

O urm easurements suggest the kinetics of evaporation can strongly a ect the structure of NCS formation. 2D NCSs can form exponentially at the liquid-air interface when the evaporation is fast enough to induce nanocrystal accumulation at the liquid-air interface, whereas under a much slower evaporation condition, nanocrystals can di use away from the interface and 3D NCSs can eventually form inside the droplet. The kinetics driven self-assem bly process observed in our nanocrystal colloidal system, m ight also play an important role in other complex systems. Exploring these systems using real-time x-ray scattering techniques should enable us to better control the organization of nanoscale building blocks, and also study m any interesting phenom ena, such as particle and dom ain dynam ics and order-to-disorder phase transition.

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